

Search Notes



Application/Control No.

10/754,200

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

NGUYEN ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	114	9/16/2006	HN
	165	Text search using EASS	
714	6		
Text search updated above		1/24/07	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG - Pub	Text search		
		1/21/07	HN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST Search His. is attaches	9/16/2006	HN
NPL Search using terms similar to East Search		
Inventorship search		
updated EASS search	1/21/07	HN